

WM8152

Single Channel 16-bit CIS/CCD AFE with 4-bit Wide Output

DESCRIPTION

The WM8152 is a 16-bit analogue front end/digitiser IC which processes and digitises the analogue output signals from CCD sensors or Contact Image Sensors (CIS) at pixel sample rates of up to 12MSPS.

The device includes a complete analogue signal processing channel containing Reset Level Clamping, Correlated Double Sampling, Programmable Gain and Offset adjust functions. Internal multiplexers allow fast switching of offset and gain for line-by-line colour processing. The output from this channel is time multiplexed into a high-speed 16-bit Analogue to Digital Converter. The digital output data is available in 4-bit wide multiplexed format.

An internal 4-bit DAC is supplied for internal reference level generation. This may be used to reference CIS signals or during Reset Level Clamping to clamp CCD signals. An external reference level may also be supplied. ADC references are generated internally, ensuring optimum performance from the device.

Using an analogue supply voltage of 5V, a digital core voltage of 5V, and a digital interface supply of either 5V or 3.3V, the WM8152 typically only consumes 225mW when operating from a single 5V supply.

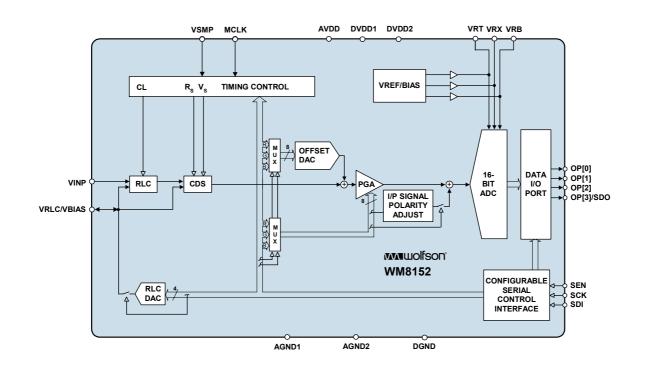
FEATURES

- 16-bit ADC
- 12MSPS conversion rate
- Low power 225mW typical
- 5V single supply or 5V/3.3V dual supply operation
- Single channel operation
- Correlated double sampling
- Programmable gain (8-bit resolution)
- Programmable offset adjust (8-bit resolution)
- Programmable clamp voltage
- 4-bit wide multiplexed data output format
- Internally generated voltage references
- 20-lead SSOP package
- Serial control interface

APPLICATIONS

- Flatbed and sheetfeed scanners
- USB compatible scanners
- Multi-function peripherals
- High-performance CCD sensor interface

BLOCK DIAGRAM



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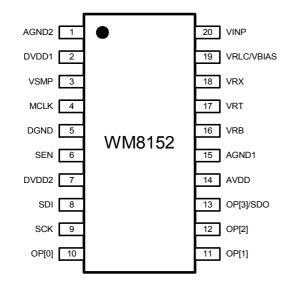
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PIN CONFIGURATION



ORDERING INFORMATION

DEVICE	TEMPERATURE RANGE	PACKAGE	MOISTURE SENSITIVITY LEVEL	PEAK SOLDERING TEMPERATURE
WM8152SCDS/V	0 to 70°C	20-lead SSOP (Pb free)	MSL2	260°C
WM8152SCDS/RV	0 to 70°C	20-lead SSOP (Pb free, tape and reel)	MSL2	260°C

Note:

Reel quantity = 2,000



PIN DESCRIPTION

PIN	NAME	TYPE	DESCRIPTION				
1	AGND2	Supply	Analogue ground (0V).				
2	DVDD1	Supply	Digital core (logic ar	nd clock generator) sup	pply (5V)		
3	VSMP	Digital input	Video sample synch	ronisation pulse.			
4	MCLK	Digital input		lock is applied at N timereafter depending on i			
5	DGND	Supply	Digital ground (0V).				
6	SEN	Digital input	Enables the serial ir	nterface when high.			
7	DVDD2	Supply	Digital supply (5V/3.	3V), all digital I/O pins.			
8	SDI	Digital input	Serial data input.				
9	SCK	Digital input	Serial clock.				
			Digital multiplexed of	output data bus.			
			ADC output data (d	15:d0) is available in 4-	bit multiplexed form	nat as shown below.	
			Α	В	С	D	
10	OP[0]	Digital output	d12	d8	d4	d0	
11	OP[1]	Digital output	d13	d9	d5	d1	
12	OP[2]	Digital output	d14	d10	d6	d2	
13	OP[3]/SDO	Digital output	d15	d11	d7	d3	
			address bit 4=1 and	P[3]/SDO may be used SEN has been pulsed section for further detai	high. See Serial In		
14	AVDD	Supply	Analogue supply (5)	/)			
15	AGND1	Supply	Analogue ground (0	V).			
16	VRB	Analogue output	Lower reference vol This pin must be co	tage. nnected to AGND via a	decoupling capaci	itor.	
17	VRT	Analogue output	Upper reference voltage. This pin must be connected to AGND via a decoupling capacitor.				
18	VRX	Analogue output	Input return bias voltage. This pin must be connected to AGND via a decoupling capacitor.				
19	VRLC/VBIAS	Analogue I/O	Selectable analogue output voltage for RLC or single-ended bias reference. This pin would typically be connected to AGND via a decoupling capacitor. VRLC can be externally driven if programmed Hi-Z.				
20	VINP	Analogue input	Video input.				



ABSOLUTE MAXIMUM RATINGS

Absolute Maximum Ratings are stress ratings only. Permanent damage to the device may be caused by continuously operating at or beyond these limits. Device functional operating limits and guaranteed performance specifications are given under Electrical Characteristics at the test conditions specified.



ESD Sensitive Device. This device is manufactured on a CMOS process. It is therefore generically susceptible to damage from excessive static voltages. Proper ESD precautions must be taken during handling and storage of this device.

Wolfson tests its package types according to IPC/JEDEC J-STD-020B for Moisture Sensitivity to determine acceptable storage conditions prior to surface mount assembly. These levels are:

 $\label{eq:MSL1} MSL1 = unlimited floor life at <\!\!30^\circ\text{C} / 85\% \mbox{ Relative Humidity. Not normally stored in moisture barrier bag.} \\ MSL2 = out of bag storage for 1 year at <\!\!30^\circ\text{C} / 60\% \mbox{ Relative Humidity. Supplied in moisture barrier bag.} \\ \end{tabular}$

MSL3 = out of bag storage for 168 hours at $<30^{\circ}C / 60\%$ Relative Humidity. Supplied in moisture barrier bag.

The Moisture Sensitivity Level for each package type is specified in Ordering Information.

CONDITION	MIN	MAX
Analogue supply voltage: AVDD	GND - 0.3V	GND + 7V
Digital core voltage: DVDD1	GND - 0.3V	GND + 7V
Digital IO supply voltage: DVDD2	GND - 0.3V	GND + 7V
Digital ground: DGND	GND - 0.3V	GND + 0.3V
Analogue grounds: AGND1 – 2	GND - 0.3V	GND + 0.3V
Digital inputs, digital outputs and digital I/O pins	GND - 0.3V	DVDD2 + 0.3V
Analogue input (VINP)	GND - 0.3V	AVDD + 0.3V
Other pins	GND - 0.3V	AVDD + 0.3V
Operating temperature range: T _A	0°C	+70°C
Storage temperature after soldering	-65°C	+150 [°] C
Package body temperature (soldering, 10 seconds)		+260°C
Package body temperature (soldering, 2 minutes)		+183°C

Notes:

1. GND denotes the voltage of any ground pin.

2. AGND1, AGND2 and DGND pins are intended to be operated at the same potential. Differential voltages between these pins will degrade performance.

RECOMMENDED OPERATING CONDITIONS

CONDITION		SYMBOL	MIN	TYP	MAX	UNITS
Operating temperature range		T _A	0		70	°C
Analogue supply voltage		AVDD	4.75	5.0	5.25	V
Digital core supply voltage		DVDD1	4.75	5.0	5.25	V
Digital I/O supply voltage	5V I/O	DVDD2	4.75	5.0	5.25	V
	3.3V I/O	DVDD2	2.97	3.3	3.63	V

THERMAL PERFORMANCE

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Performance						
Thermal resistance – junction to case	$R_{ extsf{ heta}JC}$	T - 25°C		32.2		°C/W
Thermal resistance – junction to ambient	R _{θJA}	T _{ambient} = 25°C		81.1		°C/W

Notes:

1. Figures given are for package mounted on 4-layer FR4 according to JESD51-5 and JESD51-7.



ELECTRICAL CHARACTERISTICS

Test Conditions

AVDD = DVDD1 = 5.0V, DVDD2 = 3.3V, AGND = DGND = 0V, $T_A = 25^{\circ}C$, MCLK = 24MHz unless otherwise stated.

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Overall System Specification (inc	luding 16-bit A	DC, PGA, Offset and CDS	functions)			
Full-scale input voltage range		Max Gain		0.30		Vp-p
(see Note 1)		Min Gain		3.22		Vp-p
Input signal limits (see Note 2)	VIN		0		VDD	V
Full-scale transition error		Gain = 0dB; PGA[7:0] = 07(hex)	-50	10	+50	mV
Zero-scale transition error		Gain = 0dB; PGA[7:0] = 07(hex)	-50	10	+50	mV
Differential non-linearity	DNL			1.25		LSB
Integral non-linearity	INL			25		LSB
Total output noise		Min Gain		4.5		LSB rms
		Max Gain		14		LSB rms
References						
Upper reference voltage	VRT			2.70		V
Lower reference voltage	VRB			1.45		V
Input return bias voltage	VRX		1.55	1.65	1.75	V
Diff. reference voltage (VRT-VRB)	V _{RTB}		1.15	1.25	1.35	V
Output resistance VRT, VRB, VRX				1		Ω
VRLC/Reset-Level Clamp (RLC)						
RLC switching impedance			20	50	100	Ω
VRLC short-circuit current			1.86	2	4.5	mA
VRLC output resistance				2		Ω
VRLC Hi-Z leakage current		VRLC = 0 to AVDD			1	μA
RLCDAC resolution				4		bits
RLCDAC step size, RLCDAC = 0	V _{RLCSTEP}	AVDD = 5.0V	0.23	0.25	0.27	V/step
RLCDAC step size, RLCDAC = 1	V _{RLCSTEP}		0.14	0.16	0.20	V/step
RLCDAC output voltage at code 0(hex), RLCDACRNG = 0	V _{RLCBOT}	AVDD = 5.0V	0.34	0.39	0.44	V
RLCDAC output voltage at code 0(hex), RLCDACRNG = 1	V _{RLCBOT}		0.20	0.26	0.31	V
RLCDAC output voltage at code F(hex) RLCDACRNG, = 0	V _{RLCTOP}	AVDD = 5.0V	4.0	4.16	4.3	V
RLCDAC output voltage at code F(hex), RLCDACRNG = 1	VRLCTOP		2.56	2.66	2.76	V
Offset DAC, Monotonicity Guaran	teed		•	•		•
Resolution				8		bits
Differential non-linearity	DNL			0.1	0.5	LSB
Integral non-linearity	INL			0.25	1	LSB
Step size				2.04		mV/step
Output voltage		Code 00(hex)	-247	-260	-273	mV
		Code FF(hex)	+247	+260	+273	mV

Notes:

1. **Full-scale input voltage** denotes the peak input signal amplitude that can be gained to match the ADC input range.

2. Input signal limits are the limits within which the full-scale input voltage signal must lie.



Production Data

Test Conditions

AVDD = DVDD1 = 5.0V, DVDD2 = 3.3V, AGND = DGND = 0V, $T_A = 25^{\circ}C$, MCLK = 24MHz unless otherwise stated.

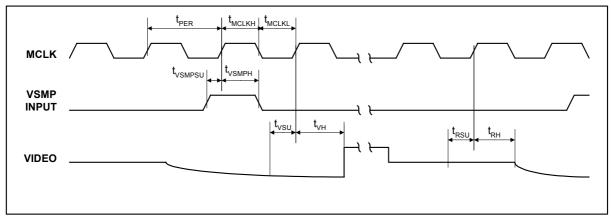
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	ТҮР	MAX	UNIT
Programmable Gain Amplifier			- 1 - 1			
Resolution				8		bits
Gain equation			0.7	$8 + \frac{PGA[7:0] \times 7}{255}$	57	V/V
Max gain	G _{MAX}		6.8	8.35	8.7	V/V
Min gain	G _{MIN}		0.75	0.78	0.82	V/V
Gain error				1	2	%
Internal channel offset	V _{OFF}			10		mV
Analogue to Digital Converter			· · · ·			
Resolution				16		bits
Maximum Speed			12			MSPS
Full-scale input range	V _{FS}			2.5		V
(2*(VRT-VRB))						
DIGITAL SPECIFICATIONS						
Digital Inputs						
High level input voltage	VIH		0.7 * DVDD2			V
Low level input voltage	VIL				0.2 * DVDD2	V
High level input current	I _{IH}				1	μA
Low level input current	I _{IL}				1	μA
Input capacitance	Cı			5		pF
Digital Outputs						
High level output voltage	V _{OH}	I _{OH} = 1mA	DVDD2 - 0.5			V
Low level output voltage	V _{OL}	I _{OL} = 1mA			0.5	V
Supply Currents						
Total supply current – active				45		mA
Total analogue AVDD, supply current – active	I _{AVDD}			41		mA
Total digital core, DVDD1, supply current – active				3		mA
Digital I/O supply current, DVDD2 – active (see note 3)	I _{DVDD2}			3		mA
Supply current – full power down mode				300	400	μA

Notes:

3. Digital I/O supply current depends on the capacitive load attached to the pin. The Digital I/O supply current is measured with approximately 50pF attached to the pin.



INPUT VIDEO SAMPLING





Note:

1. See Page 15 (Programmable VSMP Detect Circuit) for video sampling description.

Test Conditions

VDD = 5.0V, DVDD = 3.3V, AGND = DGND = 0V, T_A = 25°C, MCLK = 24MHz unless otherwise stated.

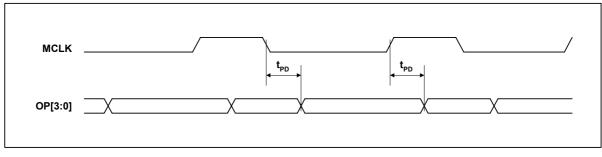
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS
MCLK period	t _{PER}		41.6			ns
MCLK high period	t _{MCLKH}		18.8			ns
MCLK low period	t _{MCLKL}		18.8			ns
VSMP set-up time	tvsmps∪		6			ns
VSMP hold time	t _{VSMPH}		3			ns
Video level set-up time	t _{VSU}		10			ns
Video level hold time	t _{∨H}		3			ns
Reset level set-up time	t _{RSU}		10			ns
Reset level hold time	t _{RH}		3			ns

Notes:

1. t_{VSU} and t_{RSU} denote the set-up time required after the input video signal has settled.

2. Parameters are measured at 50% of the rising/falling edge.

OUTPUT DATA TIMING





Test Conditions

VDD = 5.0V, DVDD = 3.3V, AGND = DGND = 0V, T_A = 25°C, MCLK = 24MHz unless otherwise stated.

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Output propagation delay	t _{PD}	I _{OH} = 1mA, I _{OL} = 1mA			20	ns



SERIAL INTERFACE

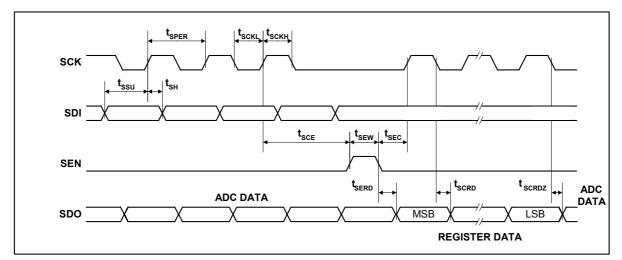


Figure 3 Serial Interface Timing

Test Conditions VDD = 5.0V, DVDD = 3.3V, AGND = DGND = 0V, T_A = 25°C, MCLK = 24MHz unless otherwise stated.

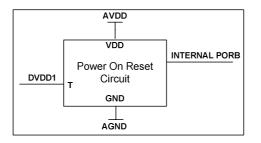
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS
SCK period	t _{SPER}		41.6			ns
SCK high	tscкн		18.8			ns
SCK low	t _{SCKL}		18.8			ns
SDI set-up time	t _{SSU}		6			ns
SDI hold time	t _{SH}		6			ns
SCK to SEN set-up time	t _{SCE}		12			ns
SEN to SCK set-up time	t _{SEC}		12			ns
SEN pulse width	t _{SEW}		25			ns
SEN low to SDO = Register data	tserd				30	ns
SCK low to SDO = Register data	t _{SCRD}				30	ns
SCK low to SDO = ADC data	t _{SCRDZ}				30	ns

Note:

1. Parameters are measured at 50% of the rising/falling edge



INTERNAL POWER ON RESET CIRCUIT





The WM8152 includes an internal Power-On-Reset Circuit, as shown in Figure 4, which is used to reset the digital logic into a default state after power up. The POR circuit is powered from AVDD and monitors DVDD1. It asserts PORB low if AVDD or DVDD1 is below a minimum threshold.

The power supplies can be brought up in any order but is important that either AVDD is brought up and is stable before DVDD comes up or vice versa as shown in Figure 5 and Figure 6.

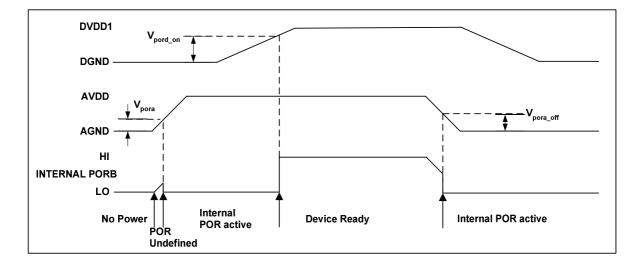
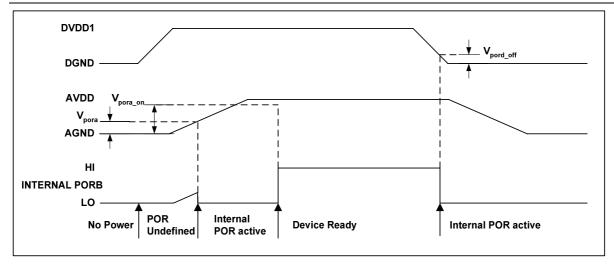


Figure 5 Typical Power up Sequence where AVDD is Powered before DVDD1

Figure 5 shows a typical power-up sequence where AVDD is powered up first. When AVDD rises above the minimum threshold, Vpora, there is enough voltage for the circuit to guarantee PORB is asserted low and the chip is held in reset. In this condition, all writes to the control interface are ignored. Now AVDD is at full supply level. Next DVDD1 rises to Vpord_on and PORB is released high and all registers are in their default state and writes to the control interface may take place.

On power down, where AVDD falls first, PORB is asserted low whenever AVDD drops below the minimum threshold Vpora_off.





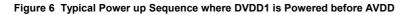


Figure 6 shows a typical power-up sequence where DVDD1 is powered up first. It is assumed that DVDD1 is already up to specified operating voltage. When AVDD goes above the minimum threshold, Vpora, there is enough voltage for the circuit to guarantee PORB is asserted low and the chip is held in reset. In this condition, all writes to the control interface are ignored. When AVDD rises to Vpora_on, PORB is released high and all registers are in their default state and writes to the control interface may take place.

On power down, where DVDD1 falls first, PORB is asserted low whenever DVDD1 drops below the minimum threshold Vpord_off.

SYMBOL	ТҮР	UNIT
V _{pora}	0.6	V
V _{pora_on}	1.2	V
V _{pora_off}	0.6	V
V _{pord_on}	0.7	V
V _{pord_off}	0.6	V

Table 1 Typical POR Operation (typical values, not tested)

Note: It is recommended that every time power is cycled to the WM8199 a software reset is written to the software register to ensure that the contents of the control registers are at their default values before carrying out any other register writes.



DEVICE DESCRIPTION

INTRODUCTION

A block diagram of the device showing the signal path is presented on Page 1.

The WM8152 processes the sampled video signal on VINP with respect to the video reset level or an internally/externally generated reference level through the analogue processing channel.

This processing channel consists of an Input Sampling block with optional Reset Level Clamping (RLC) and Correlated Double Sampling (CDS), an 8-bit programmable offset DAC and an 8-bit Programmable Gain Amplifier (PGA).

The ADC then converts each resulting analogue signal to a 16-bit digital word. The digital output from the ADC is presented on a 4-bit wide bus.

On-chip control registers determine the configuration of the device, including the offsets and gains applied to each channel. These registers are programmable via a serial interface.

INPUT SAMPLING

The WM8152 has a single analogue processing channel and ADC which can be used in a flexible manner to process both monochrome and line-by-line colour inputs.

Monochrome: VINP is sampled, processed by the analogue channel, and converted by the ADC. The same offset DAC and PGA register values are always applied.

Colour Line-by-Line: VINP is sampled and processing by the analogue channel before being converted by the ADC. The gains and offset register values applied to the PGA and offset DAC can be switched between the independent Red, Green and Blue digital registers (e.g. Red \rightarrow Green \rightarrow Blue \rightarrow Red...) at the start of each line in order to facilitate line-by-line colour operation. The INTM[1:0] bits determine which register contents are applied (see Table 2) to the PGA and offset DAC. By using the INTM[1:0] bits to select the desired register values only one register write is required at the start of each new colour line.

RESET LEVEL CLAMPING (RLC)

To ensure that the signal applied to the WM8152 VINP pin lies within the valid input range (0V to VDD) the CCD output signal is usually level shifted by coupling through a capacitor, C_{IN} . When active, the RLC circuit clamps the WM8152 side of this capacitor to a suitable voltage during the CCD reset period. The RLCINT register bit controls is used to activate the Reset Level Clamp circuit.

A typical input configuration is shown in Figure 7. The Timing Control Block generates an internal clamp pulse, CL, from MCLK and VSMP (when RLCINT is high). When CL is active the voltage on the WM8152 side of C_{IN}, at VINP, is forced to the VRLC/VBIAS voltage (V_{VRLC}) by closing switch 1. When the CL pulse turns off, switch 1 opens the voltage at VINP initially remains at V_{VRLC} but any subsequent variation in sensor voltage (from reset to video level) will couple through C_{IN} to VINP.

RLC is compatible with both CDS and non-CDS operating modes, as selected by switch 2. Refer to the CDS/non-CDS Processing section.



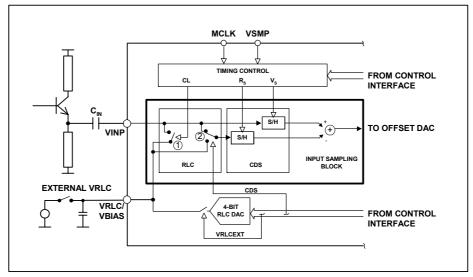


Figure 7 Reset Level Clamping and CDS Circuitry

Reset Level Clamping is controlled by register bit RLCINT. Figure 8 illustrates the effect of the RLCINT bit for a typical CCD waveform, with CL applied during the reset period.

The RLCINT register bit is sampled on the positive edge of MCLK that occurs during each VSMP pulse. The sampled level, high (or low) controls the presence (or absence) of the internal CL pulse on the next reset level. The position of CL can be adjusted by using control bits CDSREF[1:0] (Figure 9).

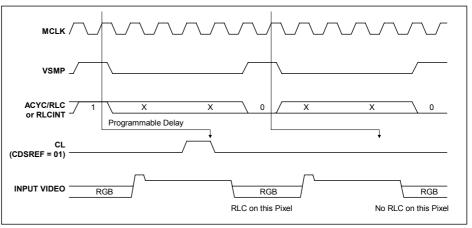


Figure 8 Relationship of RLCINT, MCLK and VSMP to Internal Clamp Pulse, CL

The VRLC/VBIAS pin can be driven internally by a 4-bit DAC (RLCDAC) by writing to control bits RLCV[3:0]. The RLCDAC range and step size may be increased by writing to control bit RLCDACRNG. Alternatively, the VRLC/VBIAS pin can be driven externally by writing to control bit VRLCEXT to disable the RLCDAC and then applying a d.c. voltage to the pin.

CDS/NON-CDS PROCESSING

For CCD type input signals, the signal may be processed using CDS, which will remove pixel-by-pixel common mode noise. For CDS operation, the video level is processed with respect to the video reset level, regardless of whether RLC has been performed. To sample using CDS, control bit CDS must be set to 1 (default), this sets switch 2 into the position shown in (Figure 7) and causes the signal reference to come from the video reset level. The time at which the reset level is sampled, by clock R_s/CL , is adjustable by programming control bits CDSREF[1:0], as shown in Figure 9.



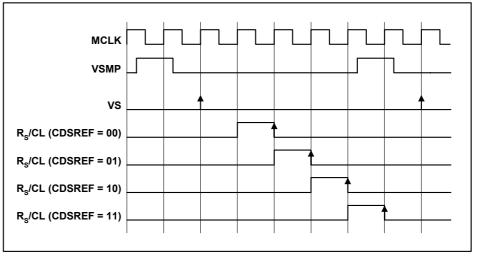


Figure 9 Reset Sample and Clamp Timing

For CIS type sensor signals, non-CDS processing is used. In this case, the video level is processed with respect to the voltage on pin VRLC/VBIAS, generated internally or externally as described above. The VRLC/VBIAS pin is sampled by R_s at the same time as V_s samples the video level in this mode; non-CDS processing is achieved by setting switch 2 in the lower position, CDS = 0.

OFFSET ADJUST AND PROGRAMMABLE GAIN

The output from the CDS block is a differential signal, which is added to the output of an 8-bit Offset DAC to compensate for offsets and then amplified by an 8-bit PGA. The gain and offset can be set for each of three colours by writing to control bits DACx[7:0] and PGAx[7:0] (where x can be R, G or B).

In colour line-by-line mode the gain and offset coefficients that are applied to the PGA and offset DAC can be multiplexed by control of the INTM[1:0] bits as shown in Table 2.

INTM[1:0]	DESCRIPTION
00	Red offset and gain registers are applied to offset DAC and PGA (DACR[7:0] and PGAR[7:0])
01	Green offset and gain registers applied to offset DAC and PGA (DACG[7:0] and PGAG[7:0])
10	Blue offset and gain registers applied to offset DAC and PGA (DACB[7:0] and PGAB[7:0])
11	Reserved.

Table 2 Offset DAC and PGA Register Control

The gain characteristic of the WM8152 PGA is shown in Figure 10. Figure 11 shows the maximum input voltage (at VINP) that can be gained up to match the ADC full-scale input range (2.5V).

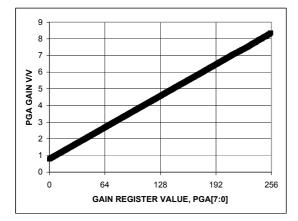


Figure 10 PGA Gain Characteristic

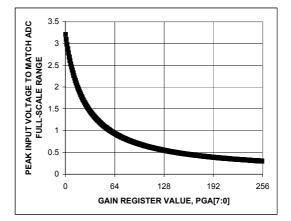


Figure 11 Peak Input Voltage to Match ADC Full-scale



ADC INPUT BLACK LEVEL ADJUST

The output from the PGA should be offset to match the full-scale range of the ADC ($V_{FS} = 2.5V$). For negative-going input video signals, a black level (zero differential) output from the PGA should be offset to the top of the ADC range by setting register bits PGAFS[1:0]=10. For positive going input signal the black level should be offset to the bottom of the ADC range by setting PGAFS[1:0]=11. Bipolar input video is accommodated by setting PGAFS[1:0]=00 or PGAFS[1:0]=01 (zero differential input voltage gives mid-range ADC output).

OVERALL SIGNAL FLOW SUMMARY

Figure 12 represents the processing of the video signal through the WM8152.

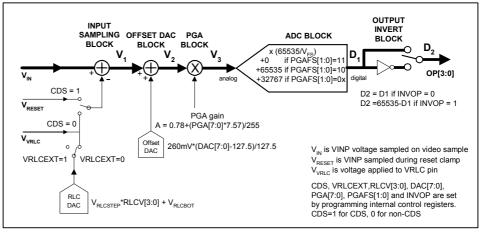


Figure 12 Overall Signal Flow

The **INPUT SAMPLING BLOCK** produces an effective input voltage **V**₁. For CDS, this is the difference between the input video level V_{IN} and the input reset level V_{RESET}. For non-CDS this is the difference between the input video level V_{IN} and the voltage on the VRLC/VBIAS pin, V_{VRLC}, optionally set via the RLC DAC.

The **OFFSET DAC BLOCK** then adds the amount of fine offset adjustment required to move the black level of the input signal towards 0V, producing V_2 .

The **PGA BLOCK** then amplifies the white level of the input signal to maximise the ADC range, outputting voltage V_3 .

The ADC BLOCK then converts the analogue signal, V_3 , to a 16-bit unsigned digital output, D_1 .

The digital output is then inverted, if required, through the OUTPUT INVERT BLOCK to produce D2.

CALCULATING OUTPUT FOR ANY GIVEN INPUT

The following equations describe the processing of the video and reset level signals through the WM8152. The values of $V_1 V_2$ and V_3 are often calculated in reverse order during device setup. The PGA value is written first to set the input Voltage range, the Offset DAC is then adjusted to compensate for any Black/Reset level offsets and finally the RLC DAC value is set to position the reset level correctly during operation.

Note: Refer to WAN0123 for detailed information on device calibration procedures.



INPUT SAMPLING BLOCK: INPUT SAMPLING AND REFERENCING

If CDS = 1, (i.e. CDS operation) the previously sampled reset level, V_{RESET} , is subtracted from the input video.

 $V_1 = V_{IN} - V_{RESET}$ Eqn. 1

If CDS = 0, (non-CDS operation) the simultaneously sampled voltage on pin VRLC is subtracted instead.

 $V_1 = V_{IN} - V_{VRLC}$ Eqn. 2

If VRLCEXT = 1, V_{VRLC} is an externally applied voltage on pin VRLC/VBIAS.

If VRLCEXT = 0, V_{VRLC} is the output from the internal RLC DAC.

VVRLC = (VRLCSTEP * RLCV[3:0]) + VRLCBOT Eqn. 3

V_{RLCSTEP} is the step size of the RLC DAC and V_{RLCBOT} is the minimum output of the RLC DAC.

OFFSET DAC BLOCK: OFFSET (BLACK-LEVEL) ADJUST

The resultant signal V_1 is added to the Offset DAC output.

PGA NODE: GAIN ADJUST

The signal is then multiplied by the PGA gain,

V ₃ =	V ₂ * [0.78+(PGA[7:0]*7.57)/255]	Eqn. 5
------------------	--	--------

ADC BLOCK: ANALOGUE-DIGITAL CONVERSION

The analogue signal is then converted to a 16-bit unsigned number, with input range configured by PGAFS[1:0].

D₁[15:0] = INT{ (**V**₃/V_{FS}) * 65535} + 32767 PGAFS[1:0] = 00 or 01 Eqn. 6

$D_1[15:0] = INT\{ (V_3)$	/V _{FS}) * 65535}	PGAFS[1:0] = 11	Eqn. 7

D₁[15:0] = INT{ (**V**₃/V_{FS}) * 65535} + 65535 PGAFS[1:0] = 10 Eqn. 8

where the ADC full-scale range, V_{FS} = 2.5V

if $D_1[15:0] < 0$ $D_1[15:0] = 0$

if **D**₁[15:0] > 65535 **D**₁[15:0] = 65535

OUTPUT INVERT BLOCK: POLARITY ADJUST

The polarity of the digital output may be inverted by control bit INVOP.

D ₂ [15:0] = D ₁ [15:0]	(INVOP = 0)	Eqn. 9
D ₂ [15:0] = 65535 - D ₁ [15:0]	(INVOP = 1)	Eqn. 10



OUTPUT DATA FORMAT

The digital data output from the ADC is available to the user in 4-bit wide multiplexed. Latency of valid output data with respect to VSMP is programmable by writing to control bits DEL[1:0]. The latency for each mode is shown in the Operating Mode Timing Diagrams section.

Figure 13 shows the output data formats for Mode 1 and 3 - 6. Figure 14 shows the output data formats for Mode 2. Table 3 summarises the output data obtained for each format.

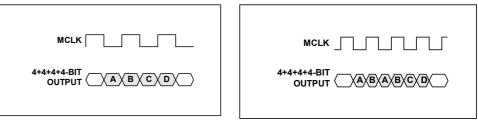


Figure 13 Output Data Formats

(Modes 1, 3, 4)

Figure 14 Output Data Formats (Mode 2)

OUTPUT FORMAT	OUTPUT PINS	Ουτρυτ
4+4+4+4-bit (nibble)	OP[3:0]	A = d15, d14, d13, d12 B = d11, d10, d9, d8 C = d7, d6, d5, d4 D = d3, d2, d1, d0

Table 3 Details of Output Data Shown in Figure 13 and Figure 14



CONTROL INTERFACE

The internal control registers are programmable via the serial digital control interface. The register contents can be read back via the serial interface on pin OP[3]/SDO.

Note: It is recommended that a software reset is carried out after the power-up sequence, before writing to any other register. This ensures that all registers are set to their default values (as shown in Table 5).

SERIAL INTERFACE: REGISTER WRITE

Figure 15 shows register writing in serial mode. Three pins, SCK, SDI and SEN are used. A six-bit address (a5, 0, a3, a2, a1, a0) is clocked in through SDI, MSB first, followed by an eight-bit data word (b7, b6, b5, b4, b3, b2, b1, b0), also MSB first. Each bit is latched on the rising edge of SCK. When the data has been shifted into the device, a pulse is applied to SEN to transfer the data to the appropriate internal register. Note all valid registers have address bit a4 equal to 0 in write mode.

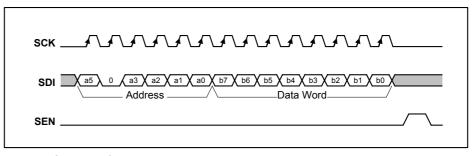


Figure 15 Serial Interface Register Write

A software reset is carried out by writing to Address "000100" with any value of data, (i.e. Data Word = XXXXXXXX.

SERIAL INTERFACE: REGISTER READ-BACK

Figure 16 shows register read-back in serial mode. Read-back is initiated by writing to the serial bus as described above but with address bit a4 set to 1, followed by an 8-bit dummy data word. Writing address (a5, 1, a3, a2, a1, a0) will cause the contents (d7, d6, d5, d4, d3, d2, d1, d0) of corresponding register (a5, 0, a3, a2, a1, a0) to be output MSB first on pin SDO (on the falling edge of SCK). Note that pin SDO is shared with an output pin, OP[3], so no data can be read when reading from a register. The next word may be read in to SDI while the previous word is still being output on SDO.

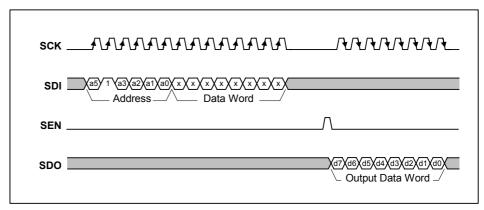


Figure 16 Serial Interface Register Read-back

TIMING REQUIREMENTS

To use this device a master clock (MCLK) of up to 24MHz and a per-pixel synchronisation clock (VSMP) of up to 12MHz are required. These clocks drive a timing control block, which produces internal signals to control the sampling of the video signal. MCLK to VSMP ratios and maximum sample rates for the various modes are shown in Table 4.



PROGRAMMABLE VSMP DETECT CIRCUIT

The VSMP input is used to determine the sampling point and frequency of the WM8152. Under normal operation a pulse of 1 MCLK period should be applied to VSMP at the desired sampling frequency (as shown in the Operating Mode Timing Diagrams) and the input sample will be taken on the first rising MCLK edge after VSMP has gone low. However, in certain applications such a signal may not be readily available. The programmable VSMP detect circuit in the WM8152 allows the sampling point to be derived from any signal of the correct frequency, such as a CCD shift register clock, when applied to the VSMP pin.

When enabled, by setting the VSMPDET control bit, the circuit detects either a rising or falling edge (determined by POSNNEG control bit) on the VSMP input pin and generates an internal VSMP pulse. This pulse can optionally be delayed by a number of MCLK periods, specified by the VDEL[2:0] bits. Figure 17 shows the internal VSMP pulses that can be generated by this circuit for a typical clock input signal. The internal VSMP pulse is then applied to the timing control block in place of the normal VSMP pulse provided from the input pin. The sampling point then occurs on the first rising MCLK edge after this internal VSMP pulse, as shown in the Operating Mode Timing Diagrams.

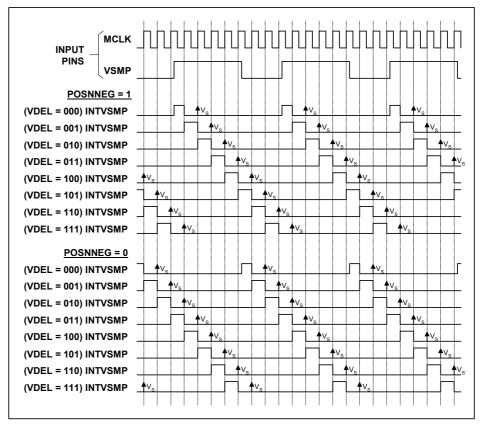


Figure 17 Internal VSMP Pulses Generated by Programmable VSMP Detect Circuit



The ADC reference voltages are derived from an internal bandgap reference, and buffered to pins VRT and VRB, where they must be decoupled to ground. Pin VRX is driven by a similar buffer, and also requires decoupling. The output buffer from the RLCDAC also requires decoupling at pin VRLC/VBIAS when this is configured as an output.

POWER SUPPLY

The WM8152 can run from a 5V single supply or from split 5V (core) and 3.3V (digital interface) supplies.

POWER MANAGEMENT

Power management for the device is performed via the Control Interface. The device can be powered on or off completely by setting the EN bit low.

All the internal registers maintain their previously programmed value in power down mode and the Control Interface inputs remain active.

OPERATING MODES

Table 4 summarises the most commonly used modes, the clock waveforms required and the register contents required for CDS and non-CDS operation.

MODE	DESCRIPTION	CDS AVAILABLE	MAX SAMPLE RATE	TIMING REQUIREMENTS	REGISTER CONTENTS WITH CDS	REGISTER CONTENTS WITHOUT CDS
1	Monochrome/ Colour Line-by-Line	Yes	4MSPS	MCLK max = 24MHz MCLK:VSMP ratio is 6:1	SetReg1: 0F(hex)	SetReg1: 0D(hex)
2	Fast Monochrome/ Colour Line-by-Line	Yes	8MSPS	MCLK max = 24MHz MCLK:VSMP ratio is 3:1	Identical to Mode 1 plus SetReg3: bits 5:4 must be set to 0(hex)	Identical to Mode 1
3	Maximum speed Monochrome/ Colour Line-by-Line	No	12MSPS	MCLK max = 24MHz MCLK:VSMP ratio is 2:1	CDS not possible	SetReg1: 4D(hex)
4	Slow Monochrome/ Colour Line-by-Line	Yes	3MSPS	MCLK max = 24 MHz MCLK:VSMP ratio is $2n:1, n \ge 4$	Identical to Mode 1	Identical to Mode 1

Table 4 WM8152 Operating Modes



OPERATING MODE TIMING DIAGRAMS

The following diagrams show 4-bit multiplexed output data and MCLK, VSMP and input video requirements for operation of the most commonly used modes as shown in Table 4. The diagrams are identical for both CDS and non-CDS operation.

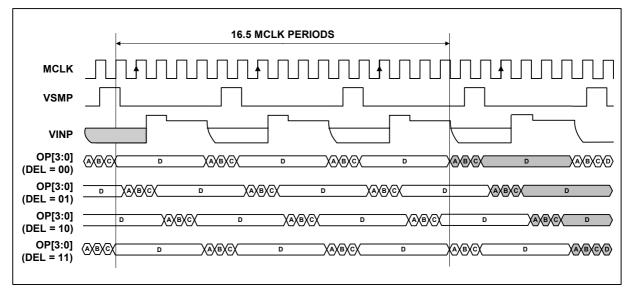


Figure 18 Mode 1 Operation

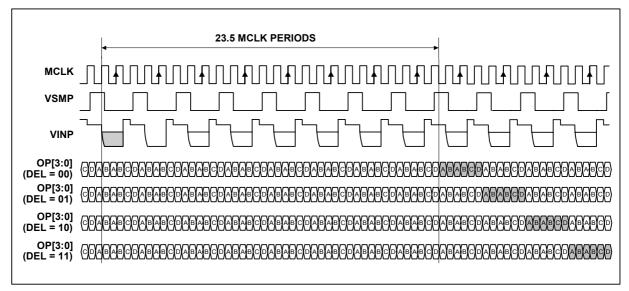


Figure 19 Mode 2 Operation



WM8152

Production Data

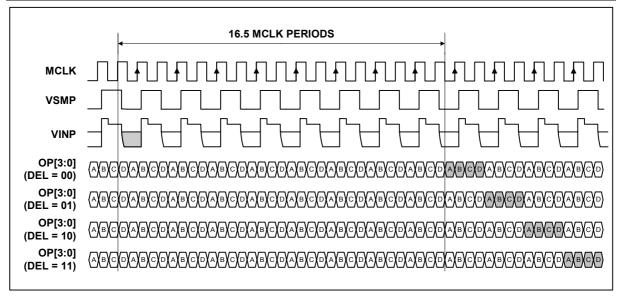
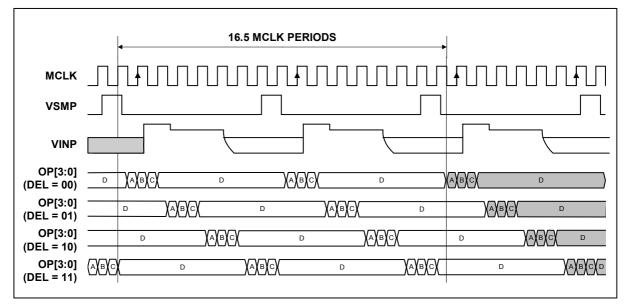


Figure 20 Mode 3 Operation







DEVICE CONFIGURATION

REGISTER MAP

The following table describes the location of each control bit used to determine the operation of the WM8152. The register map is programmed by writing the required codes to the appropriate addresses via the serial interface.

ADDRESS	DESCRIPTION	DEF	RW	BIT							
<a5:a0></a5:a0>		(hex)		b7	b6	b5	b4	b3	b2	b1	b0
000001	Setup Reg 1	0F	RW	0	MODE3	PGAFS[1]	PGAFS[0]	1	1	CDS	EN
000010	Setup Reg 2	23	RW	DEL[1]	DEL[0]	RLCDACRNG	0	VRLCEXT	INVOP	1	1
000011	Setup Reg 3	1F	RW	0	0	CDSREF [1]	CDSREF [0]	RLCV[3]	RLCV[2]	RLCV[1]	RLCV[0]
000100	Software Reset	00	W								
000110	Setup Reg 4	05	RW	0	0	INTM[1]	INTM[0]	RLCINT	1	0	1
000111	Revision Number	41	R	0	1	0	0	0	0	0	1
001000	Setup Reg 5	00	RW	0	0	0	POSNNEG	VDEL[2]	VDEL[1]	VDEL[0]	VSMPDET
001001	Test Reg 1	00	RW	TCLK	0	0	0	0	0	0	0
001010	Reserved	00	RW	0	0	0	0	0	0	0	0
001011	Reserved	00	RW	0	0	0	0	0	0	0	0
001100	Reserved	00	RW	0	0	0	0	0	0	0	0
100000	DAC Value (Red)	80	RW	DACR[7]	DACR[6]	DACR[5]	DACR[4]	DACR[3]	DACR[2]	DACR[1]	DACR[0]
100001	DAC Value (Green)	80	RW	DACG[7]	DACG[6]	DACG[5]	DACG[4]	DACG[3]	DACG[2]	DACG[1]	DACG[0]
100010	DAC Value (Blue)	80	RW	DACB[7]	DACB[6]	DACB[5]	DACB[4]	DACB[3]	DACB[2]	DACB[1]	DACB[0]
100011	DAC Value (RGB)	80	W	DAC[7]	DAC[6]	DAC[5]	DAC[4]	DAC[3]	DAC[2]	DAC[1]	DAC[0]
101000	PGA Gain (Red)	00	RW	PGAR[7]	PGAR[6]	PGAR[5]	PGAR[4]	PGAR[3]	PGAR[2]	PGAR[1]	PGAR[0]
101001	PGA Gain (Green)	00	RW	PGAG[7]	PGAG[6]	PGAG[5]	PGAG[4]	PGAG[3]	PGAG[2]	PGAG[1]	PGAG[0]
101010	PGA Gain (Blue)	00	RW	PGAB[7]	PGAB[6]	PGAB[5]	PGAB[4]	PGAB[3]	PGAB[2]	PGAB[1]	PGAB[0]
101011	PGA Gain (RGB)	00	W	PGA[7]	PGA[6]	PGA[5]	PGA[4]	PGA[3]	PGA[2]	PGA[1]	PGA[0]

Table 5 Register Map



REGISTER MAP DESCRIPTION

REGISTER	BIT NO	BIT NAME(S)	DEFAULT	DESCRIPTION		
Setup	0	EN	1	0 = complete power down, 1 = fully active.		
Register 1	1	CDS	1	Select correlated double sampling mode: 0 = single ended mode, 1 = CDS mode.		
	3:2	Reserved	11	Must be set to one		
	5:4	PGAFS[1:0]	00	Offsets PGA output to optimise the ADC range for different polarity sensor output signals. Zero differential PGA input signal gives:		
				00 = Zero output10 = Full-scale positive output(use for bipolar video)(use for negative going video)01 = Zero output11 = Full-scale negative output(use for positive going video)		
	6	MODE3	0	Required when operating in MODE3: 0 = other modes, 1 = MODE3.		
	7	Reserved	0	Must be set to zero		
Setup	1:0	Reserved	11	Must be set to one		
Register 2	2	INVOP	0	Digitally inverts the polarity of output data.		
				0 = negative going video gives negative going output,1 = negative-going video gives positive going output data.		
	3	VRLCEXT	0	When set powers down the RLCDAC, changing its output to Hi-Z, allowing VRLC/VBIAS to be externally driven.		
	4	Reserved	0	Must be set to zero		
	5	RLCDACRNG	1	Sets the output range of the RLCDAC. 0 = RLCDAC ranges from 0 to VDD (approximately), 1 = RLCDAC ranges from 0 to VRT (approximately).		
	7:6	DEL[1:0]	00	Sets the output latency in ADC clock periods.1 ADC clock period = 2 MCLK periods except in Mode 2 where 1 ADC clock period = 3 MCLK periods.00 = Minimum latency10 = Delay by two ADC clock periods01 = Delay by one ADC clock11 = Delay by three ADC clock		
				period periods		
Setup Register 3	3:0	RLCV[3:0]	1111	Controls RLCDAC driving VRLC pin to define single ended signal reference voltage or Reset Level Clamp voltage. See Electrical Characteristics section for ranges.		
	5:4	CDSREF[1:0]	01	CDS mode reset timing adjust.		
				00 = Advance 1 MCLK period10 = Retard 1 MCLK period01 = Normal11 = Retard 2 MCLK periods		
	7:6	Reserved	00	Must be set to zero		
Software				Any write to Software Reset causes all cells to be reset.		
Reset				It is recommended that a software reset be performed after a power-up before any other register writes.		
Setup	2:0	Reserved	101	Must be set to 101		
Register 4	3	RLCINT	0	This bit is used to determine whether Reset Level Clamping is enabled. 0 = RLC disabled, 1 = RLC enabled.		
	5:4	INTM[1:0]	00	Colour selection bits used in internal modes. 00 = Red, 01 = Green, 10 = Blue and 11 = Reserved. See Table 2 for details.		
	7:6	Reserved	00	Must be set to zero		

The following table describes the function of each of the control bits shown in Table 5.



Production Data

REGISTER	BIT NO	BIT NAME(S)	DEFAULT		DESCRIPTION		
Setup Register 5	0	VSMPDET	0	0 = Normal operation, signal on VSMP input pin is applied directly to Timing Control block.			
					P detect circuit is enabled generated from signal app Control block.		
	3:1	VDEL[2:0]	000	detected edge of the sig generated pulse is delay edge.	ese bits have no effect. ese bits set a programmal nal applied to the VSMP p red by VDEL MCLK period /SMP Pulses Generated f	in. The internally Is from the detected	
	4	POSNNEG	0	are detected: 0 = Negative edge on VS	s bit has no effect. s bit controls whether pos SMP pin is detected and u	0 0	
				 timing pulse. 1 = Positive edge on VSMP pin is detected and used to generate internal timing pulse. See Figure 17 for further details. 			
	7:5	Reserved	000	Must be set to zero			
Test Register 1	7	TCLK	0	0 = Normal Operation, C 1 = Internal Clock Test M multiplexed onto the OP	Node. This allows internal	timing signals to be	
				PIN	TCLK=0	TCLK=1	
				OP[3]	OP[3]	INTVSMP	
				OP[2]	OP[2]	Video sample clock	
				OP[1]	OP[1]	ADC clock	
				OP[0]	OP[0]	Reset sample clock	
Offset DAC (Red)	7:0	DACR[7:0]	1000000	Red channel offset DAC control bits.	value. Used under contro	l of the INTM[1:0]	
Offset DAC (Green)	7:0	DACG[7:0]	10000000	Green channel offset DA control bits.	C value. Used under cont	trol of the INTM[1:0]	
Offset DAC (Blue)	7:0	DACB[7:0]	10000000	Blue channel offset DAC control bits.	value. Used under contro	of the INTM[1:0]	
Offset DAC (RGB)	7:0	DAC[7:0]		A write to this register lo registers to be overwritte	cation causes the red, gre on by the new value	en and blue offset DAC	
PGA gain (Red)	7:0	PGAR[7:0]	0000000	Determines the gain of the red channel PGA according to the equation: Red channel PGA gain = [0.78+(PGAR[7:0]*7.57)/255]. Used under control of the INTM[1:0] control bits.			
PGA gain (Green)	7:0	PGAG[7:0]	00000000	Determines the gain of the green channel PGA according to the equation: Green channel PGA gain = [0.78+(PGAG[7:0]*7.57)/255]. Used under control of the INTM[1:0] control bits.			
PGA gain (Blue)	7:0	PGAB[7:0]	00000000	Blue channel PGA gain	Determines the gain of the blue channel PGA according to the equation: Blue channel PGA gain = [0.78+(PGAB[7:0]*7.57)/255]. Used under control of the INTM[1:0] control bits.		
PGA gain (RGB)	7:0	PGA[7:0]		A write to this register lo registers to be overwritte	cation causes the red, gre en by the new value	en and blue PGA gain	

Table 6 Register Control Bits



APPLICATIONS INFORMATION

RECOMMENDED EXTERNAL COMPONENTS

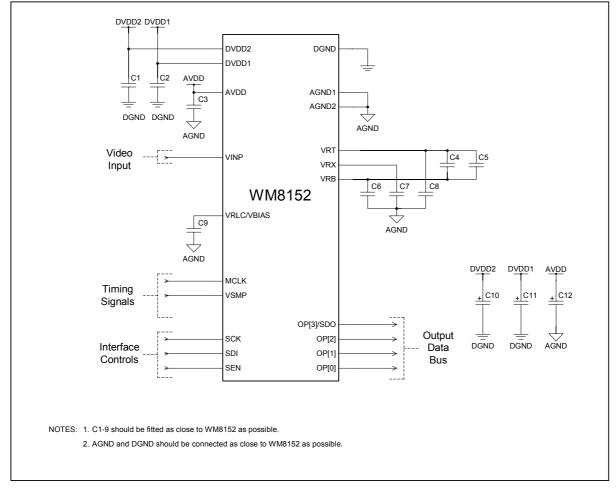


Figure 22 External Components Diagram

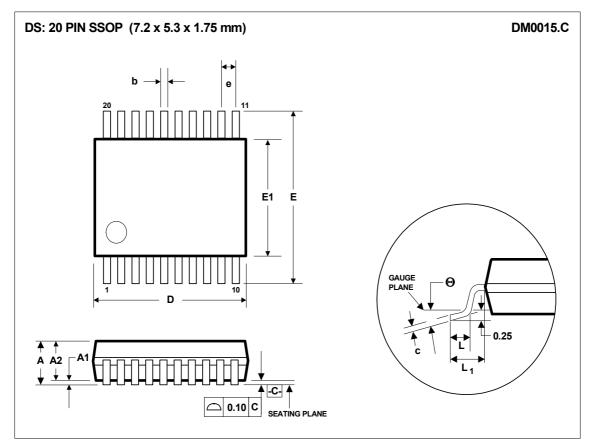
RECOMMENDED EXTERNAL COMPONENTS VALUES

COMPONENT REFERENCE	SUGGESTED VALUE	DESCRIPTION	
C1	100nF	De-coupling for DVDD2.	
C2	100nF	De-coupling for DVDD1.	
C3	100nF	De-coupling for AVDD.	
C4	10nF	High frequency de-coupling between VRT and VRB.	
C5	1μF	Low frequency de-coupling between VRT and VRB (non-polarised).	
C6	100nF	De-coupling for VRB.	
C7	100nF	De-coupling for VRX.	
C8	100nF	De-coupling for VRT.	
C9	100nF	De-coupling for VRLC.	
C10	10µF	Reservoir capacitor for DVDD2.	
C11	10µF	Reservoir capacitor for DVDD1.	
C12	10µF	Reservoir capacitor for AVDD.	

Table 7 External Components Descriptions



PACKAGE DIMENSIONS



Symbols	Dimensions (mm)						
	MIN	NOM	MAX				
Α			2.0				
A ₁	0.05						
A ₂	1.65	1.75	1.85				
b	0.22	0.30	0.38				
С	0.09		0.25				
D	6.90	7.20	7.50				
е		0.65 BSC					
E	7.40	7.80	8.20				
E1	5.00	5.30	5.60				
L	0.55	0.75	0.95				
L ₁	1.25 REF						
θ	0°	4°	8°				
REF:	JE	DEC.95, MO-1	50				

NOTES: A. ALL LINEAR DIMENSIONS ARE IN MILLIMETERS. B. THIS DRAWING IS SUBJECT TO CHANGE WITHOUT NOTICE. C. BODY DIMENSIONS DO NOT INCLUDE MOLD FLASH OR PROTRUSION, NOT TO EXCEED 0.20MM. D. MEETS JEDEC.95 MO-150, VARIATION = AE. REFER TO THIS SPECIFICATION FOR FURTHER DETAILS.



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ADDRESS:

Wolfson Microelectronics plc 20 Bernard Terrace Edinburgh EH8 9NX United Kingdom

Tel :: +44 (0)131 272 7000 Fax :: +44 (0)131 272 7001 Email :: <u>sales@wolfsonmicro.com</u>

